



BSI Standards Publication

Surface chemical analysis — Characterization of nanostructured materials

National foreword

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Surface chemical analysis — Characterization of nanostructured materials

*Analyse chimique des surfaces - Caractérisation des matériaux
nanostructurés*





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Contents

Page

Foreword	iv
Introduction	v
1 Scope	1
2 Normative references	1
3 Terms, definitions and abbreviated terms	1
4 Characterization of nanostructured materials with surface analysis methods	3
4.1 Introduction	3
4.2 Electron Spectroscopies (AES and XPS)	6
4.3 Ion-beam surface analysis methods (SIMS and LEIS)	13
4.4 Scanning probe microscopy	15
4.5 Surface characterization of carbon nanostructures	16
5 Analysis considerations, issues and challenges associated with characterization of nanostructured materials: Information for the analyst	17
5.1 Introduction	17
5.2 General considerations and analysis challenges	17
5.3 Physical properties	19
5.4 Particle stability and damage: influence of size, surface energy and confluence of energy scales	19
5.4.1 Crystal structure	20
5.4.2 Damage and probe effects	21
5.4.3 Time and environment	21
5.5 Sample mounting and preparation considerations	26
5.6 Specific considerations for analysis of nanostructured materials using XPS, AES, SIMS and SPM	27
5.6.1 Introduction	27
5.6.2 Issues related to application of XPS to nanomaterials	27
5.6.3 Issues related to the application of AES to nanostructured materials	30
5.6.4 Issues related to application of SIMS to nanoparticles	30
5.6.5 Issues related to the application of scanning probe methods to nanoparticles	32
6 General characterization needs and opportunities for nanostructured materials	33
Bibliography	34

Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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For an explanation of the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT), see www.iso.org/iso/foreword.html.

This document was prepared by Technical Committee ISO/TC 201, *Surface chemical analysis*, Subcommittee SC 7, *Electron spectroscopies*.

This second edition cancels and replaces the first edition (ISO/TR 14187:2011), which has been technically revised.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Introduction

As engineered nanomaterials of many types play an increasing role in many different technologies^[1], international organizations (including ISO, ASTM, the International Bureau of Weights and Measures (BIPM), Consultative Committee for Amount of Substance: Metrology in Chemistry (CCQM) and the Organization for Economic Cooperation and Development (OECD))^[1] are working to identify critical properties^[2] and measurements that must be understood to adequately and reproducibly define the nature of the materials being used.

A large percentage of any nanomaterial is associated with a surface or interface. Therefore, surface composition and chemistry have been identified as being part of a minimum set of chemical parameters needed to characterize nanomaterials and it would naturally seem that the wide range of tools developed for surface characterization could or should be routinely applied to these materials. Two different issues, however, have limited the impact of traditional surface analysis tools in some areas of nanoscience and nanotechnology. First, many of the tools do not have sufficient spatial resolution in three dimensions needed to analyse individual nanostructured materials (or, equivalently, variations of composition within that material). For this reason, some researchers do not consider application of the tools even though they can often provide very important information. Second, surface analytical (and other) tools are often applied to nanostructured materials without appropriately considering several analytical challenges or issues that these materials present. Such challenges include environmentally altered behaviours of nanoparticles (including effects of making measurements in vacuum), time-dependent characteristics of nanostructured materials, the influence of particle shape on analysis results, and the increased possibility of altering the structure or composition of the nanomaterial by the incident radiation (typically electrons, X-rays, or ions) during the analysis.

As noted by others including Linkov et al.^[3] there are new challenges associated with understanding and characterizing nanomaterials, “the study of nanostructures and nanomaterials requires special protocols that take into account the physical [and chemical] phenomena that occur in nanosized systems.” This document gives information on these important issues. The report first describes the types of information that can be obtained about nanostructured materials, sometimes using analytical approaches beyond those in standard applications. Second, the report examines the technical challenges generally faced when applying surface analysis tools (and often other tools) for characterization of nanostructured materials as well as those specific to each technique.

Because of the expanding use of nanostructured materials in research, development, and commercial applications as well as their natural presence in air, surface, and ground water, there is an increasing need to understand the properties and behaviours of nanostructured materials as they are synthesized or as they evolve in a particular environment. The novel and unusual properties of nanostructured materials excite scientists, technologists and the general public. However, the sometimes surprising properties of many of these materials raise reproducibility, analysis or characterization issues that sometimes are unexpected by analysts, scientists, and production engineers^[4-6]. There is an increasing awareness of reproducibility issues in many areas of science including those associated with materials, biological, computational, and chemical research^[7-11]. Inherent characteristics of nanoparticles (NPs) that make them interesting and potentially useful also make them susceptible to reproducibility challenges associated with their production, characterization, and delivery. Inconsistencies and conflicts caused by these challenges have stimulated editorials and commentaries^[5-12], scientific news items, and journal articles^[4,15-18]. Careful analysis, including surface analysis as described in this report, along with data records such as described in ISO 20579-4 for preparation of nano-objects for surface analysis can help establish the provenance of a batch of nano-objects^[19,20] providing a tool to address nano-object reproducibility issues.

Potential health and environmental concerns related to materials with unusual or unique properties increase the need to understand the chemical, physical and biological properties of these materials throughout their life cycle. It is now recognized that some early reports on the properties of nanoparticles and other nanostructured materials, including their toxicity and environmental stability, were based on inadequate characterizations^[13]. In some cases, important characterizations appear not to have been attempted or reported^[21,22]. A March 2006 article in *Small Times* magazine described a workshop designed to identify roadblocks to nanobiotech commercialization^[13] at which several experts

reported that many of the important physical characteristics needed to understand the physical and chemical properties of nanoparticles were not reported and apparently often unmeasured, especially in assessments of particle toxicity. The article further notes that the changes that these particles undergo when exposed to the environment where they are stored or used are especially important and usually unknown. In many cases, nanoparticles are coated with surfactants or contaminants, and these are often not well characterized and sometimes not adequately identified. As a result, the validity of the conclusions may be questionable. Inadequate characterization of the surface chemistry of nanoparticles has been identified as one of the areas where appropriate characterization is often lacking^[5,22]. This issue was identified also by the OECD Working Party on Manufactured Nanomaterials (WPMN) and new projects are launched under the umbrella of the Malta Initiative. One of them is the “Identification and quantification of the surface chemistry and coatings on nano- and microscale materials” where surface chemical analysis will substantially contribute.

The ISO definition of a nano-object (ISO/TS 80004-1:2015) is that, in at least one dimension, the size of the object or structure must be approximately 100 nm or less. Considerable attention is being given to the characterization of nanosized-objects (particles, rods or other shapes) that might be released into the environment and a set of minimum characterization requirements for nanoparticles for use in toxicity studies has been identified^[2]. However, the needs for nanomaterials characterization include the wide variety of nanostructured materials that are used in computers, as sensors, in batteries or fuel cells and many other types of applications. Nonetheless, the minimum characterization requirements for nanoparticles can be generalized to a wider range of materials and potential applications as shown in [Table 1](#).

Surface-analysis methods of various forms (described later) can provide information that relates to many elements in [Table 1](#) including those that appear obvious (such as surface composition and chemistry) but also includes particle or component size, presence of surface impurities, nature of surface functionality (including acidity), surface structure/morphology, near-surface variation of composition (both laterally and with depth, coating/film thickness, and electronic properties of nanostructures/films).

Surface characterization is only a subset of several nanomaterials analysis needs that are being examined by ISO/TC 229. This report on surface chemical analysis methods prepared by ISO/TC 201/SC 7 has been prepared in coordination with the overall characterization needs identified by experts in TC 201 and TC 229 as well as awareness of the objectives being addressed by ISO/TC 229. This document describes the information that can be obtained (and by which techniques), and examines some of the issues and challenges faced when performing such analyses.

Table 1 — Physical and chemical properties for characterization of nanostructured materials

Items in **bold** font are properties for which surface chemical analysis can provide useful information, as described in this document.

What does the material look like?

- **Particle/grain/film/structural unit size(s)** /size distribution
- **Grain, particle, film morphology** (shape, layered, roughness, topography)
- Agglomeration state/aggregation (e.g., do particles stick together)

What is the material made of?

- Bulk composition (including chemical composition and crystal structure)
- Bulk purity (including levels of impurities)
- **Elemental, chemical and/or phase distribution** (including surface composition and surface impurities)

What factors affect how a material interacts with its surroundings?

- Surface area
- **Surface chemistry**, including reactivity, hydrophobicity
- Surface charge

Overarching considerations to take into account when characterizing engineered nanomaterials (for toxicity studies and other applications):

- **Stability**—how do material properties (especially the surface composition, particle agglomeration, etc.) change with time (dynamic stability), storage, handling, preparation, delivery, etc.? Include solubility and the rate of material release through dissolution
 - Context/media—how do material properties change in different media or during processing (**environmental effects**); i.e., from the bulk material to dispersions to material in various biological matrices? (“as administered” characterization is considered to be particularly important)
 - Where possible, materials should be characterized sufficiently to interpret **functional behaviours**. For toxicology studies, information is required on the response to the amount of material against a range of potentially relevant dose metrics, including mass, surface area, and number concentration
-

This table is adapted from [2]. The recommendations in the initial table were developed at a workshop on ensuring appropriate material characterization in nanotoxicology studies, held at the Woodrow Wilson International Center for Scholars in Washington, DC, USA, between 28 October and 29 October, 2008; <http://www.characterizationmatters.org>.

Surface chemical analysis — Characterization of nanostructured materials

1 Scope

This document provides an introduction to (and some examples of) the types of information that can be obtained about nanostructured materials using surface-analysis tools ([Clause 5](#)). Of equal importance, both general issues or challenges associated with characterizing nanostructured materials and the specific opportunities or challenges associated with individual methods are identified ([Clause 6](#)). As the size of objects or components of materials approaches a few nanometres, the distinctions among “bulk”, “surface” and “particle” analysis blur. Although some general issues relevant to characterization of nanostructured materials are identified, this document focuses on issues specifically relevant to surface chemical analysis of nanostructured materials. A variety of analytical and characterization methods will be mentioned, but this report focuses on methods that are in the domain of ISO/TC 201 including Auger Electron Spectroscopy, X-ray photoelectron spectroscopy, secondary ion mass spectrometry, and scanning probe microscopy. Some types of measurements of nanoparticle surface properties such as surface potential that are often made in a solution are not discussed in this Report.

Although they have many similar aspects, characterization of nanometre-thick films or a uniform collection of nanometre-sized particles present different characterization challenges. Examples of methods applicable to both thin films and to particles or nano-sized objects are presented. Properties that can be determined include: the presence of contamination, the thickness of coatings, and the chemical nature of the surface before and after processing. In addition to identifying the types of information that can be obtained, the document summarizes general and technique-specific Issues that must be considered before or during analysis. These include: identification of needed information, stability and probe effects, environmental effects, specimen-handling issues, and data interpretation.

Surface characterization is an important subset of several analysis needs for nanostructured materials. The broader characterization needs for nanomaterials are within the scope of ISO/TC 229 and this document has been coordinated with experts of TC 229 Joint Working Group (JWG) 3.

This introduction to information available about nanomaterials using a specific set of surface-analysis methods cannot by its very nature be fully complete. However, important opportunities, concepts and issues have been identified and many references provided to allow the topics to be examined in greater depth as required.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 18115-1, *Surface chemical analysis — Vocabulary — Part 1: General terms and terms used in spectroscopy*

ISO 18115-2, *Surface chemical analysis — Vocabulary — Part 2: Terms used in scanning-probe microscopy*

3 Terms, definitions and abbreviated terms

For the purposes of this document, the terms and definitions given in ISO 18115-1 and ISO 18115-2 apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

— ISO Online browsing platform: available at <https://www.iso.org/obp>